Supporting Information

Laser Processing of Li-doped Mesoporous TiO₂ for Ambient-processed Mesoscopic Perovskite Solar Cells

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Keywords

Laser treatment, mesoporous TiO₂, doped-TiO₂, Ambient-processed, Perovskite solar cells



Figure S1 Humidity meter showing relative humidity 72.8% during the fabrication of the PSCs.



Figure S2 (a) J_{SC} and (b) V_{OC} (c) FF distribution for the PSCs based on the m-TiO₂ with various Li doping concentration.



Figure S3 Thermal profiles of the laser-treated Li-doped m-TiO₂ on the ITO-glass with highest treatment temperatures of (a) 700-750, (b) 800-850, and (c) 900-950 $^{\circ}$ C.



Figure S4 (a) Raman spectra of the furnace-treated undoped m-TiO₂, furnace- and laser-treated Li-doped m-TiO₂ films, (b) Raman Spectra for 3 different samples with condition of laser-treated Li-doped m-TiO₂ films at 850°C. and (c) XRD patterns of the furnace-treated undoped m-TiO₂, furnace- and laser-treated Li-doped m-TiO₂ films.



Figure S5 Tauc plots for (a) furnace-treated undoped m-TiO₂, (b) furnace-treated Li-doped m-TiO₂ and (c) laser-treated Li-doped m-TiO₂ (800-850 °C).



Figure S6 XPS high resolution profile of Ti 2p for the furnace-treated undoped m-TiO₂, Li-doped m-TiO₂ and laser-treated Li-doped m-TiO₂ films (800-850 °C).



Figure S7 Top view SEM images for (a) furnace-treated undoped m-TiO₂ film, (b) furnace-treated Li-doped m-TiO₂ film and laser-treated Li-doped m-TiO₂ films with the highest annealing temperature of (c) 700–750 °C, (d) 800–850 °C, (e) 900–950 °C (interconnected TiO₂ particles marked in purple circle, scale bar = 500 nm).



Figure S8 Top view SEM images for the perovskite film deposited on (a) furnace-treated undoped m-TiO₂ film, (b) furnace-treated Li-doped m-TiO₂ film and laser-treated Li-doped m-TiO₂ films with the highest processing temperature of (c) 700–750 °C, (d) 800–850 °C, (e) 900–950 °C (scale bar = 1 um).



Figure S9 Cross-sectional SEM view for the PSCs based on the (a) furnace-treated undoped m-TiO₂ film, (b) furnace-treated Li-doped m-TiO₂ film and laser-treated Li-doped m-TiO₂ films with the highest processing temperature of (c) 700–750 °C, (d) 800–850 °C, (e) 900–950 °C.



Figure S10 AFM topography for (a,d) furnace-treated undoped m-TiO₂, (b,e) furnace-treated Li-doped m-TiO₂ and (c,f) laser-treated Li-doped m-TiO₂ (800-850 °C).



Figure S11 Water contact measurements for (a) furnace-treated undoped m-TiO₂, (b) furnace-treated Li-doped m-TiO₂ and (c) laser-treated Li-doped m-TiO₂ (800-850 °C).



Figure S12 *I-V* curves ohmic region of the furnace-treated undoped m-TiO₂, Li-doped m-TiO₂ and laser-treated Li-doped m-TiO₂ films (800-850 °C).



Figure S13 Schematic representation of the ITO/FTO resistance measurement by two-probe method with a measure distance of 17 mm between the two electrodes.



Figure S14 Transient photo-current decay of PSCs based on furnace-treated undoped m-TiO₂, Li-doped m-TiO₂ and laser-treated Li-doped m-TiO₂ films (800-850 °C).



Figure S15 (a) J_{SC} and (b) V_{OC} (c) FF distribution for PSCs based on furnace-treated Li-doped m-TiO₂ and laser-treated Li-doped m-TiO₂ films.



Figure S16 The summary of the state-of-the-art efficiencies for ambient processed PSCs under various humidity [1–15].



Figure S17 The *J-V* curves of PSCs measured in reverse and forward scan for (a) furnace-treated pure $c-TiO_2$. (b) furnace-treated pure $m-TiO_2$, (c) furnace-treated Li doped $m-TiO_2$, and (d) laser-treated Li-doped $m-TiO_2$.



Figure S18 Temperature profiles of Li-doped m-TiO₂ films coated on FTO substrate during laser treatment with various laser parameters settings.



Figure S19 Thermal profiles of the laser-treated Li-doped m-TiO₂ on the FTO glass with peak treatment temperatures of (a) 500-550 and (b) 600-650 $^{\circ}$ C.

Table S1 Summary of photovoltaic parameters for the mesoporous PSCs with the furnace-treated undoped m-TiO₂ and Li-doped m-TiO₂ films.

Samples	Voc (V)	J_{SC} (mA·cm ⁻²)	FF (%)	Average PCE (%)	Champion PCE (%)
Undoped m-TiO ₂	1.010 ± 0.011	23.22±0.16	73.19±0.64	17.16±0.19	17.71
0.5 mg mL ⁻¹ Li- doped m-TiO ₂	1.014±0.014	23.29±0.24	73.63±0.72	17.38±0.29	17.86
1.0 mg mL ⁻¹ Li- doped m-TiO ₂	1.027±0.008	23.34±0.15	74.03±1.33	17.74±0.31	18.10
1.5 mg mL ⁻¹ Li- doped m-TiO2	1.021±0.011	23.34±0.15	73.95±0.98	17.63±0.35	18.04

Table S2 Laser processing parameters for the fabrication of Li-doped TiO₂ films.

	Temperatures (Measured by thermal cameral)	Spot area (cm²)	Ramp power density (W·cm ²)	Duration (s)	Soak power density (W•cm ²)	Duration (s)
	Laser-treated at 700-750 °C		113	14	36	3
Li-doped m-	Laser-treated at 800-850 °C		113	18	36	3
TiO ₂ /ITO	Laser-treated at 900-950 °C	196	113	22	36	3
Li-doped	Laser-treated at 500-550 °C		113	14	36	3
TiO ₂ /FTO	Laser-treated at 600-650 °C	196	113	18	36	3

Table S3 Summary of XRD peak position, peak intensity, FWHM, and crystalline size calculated using Scherrer equation for the furnace-treated undoped m-TiO₂ and furnace- and laser-treated Li-doped m-TiO₂ films.

Conditions	Peak position 2θ (°)	FWHM (°)	Peak intensity	Crystal size (nm)
Furnace-treated undoped m-TiO2 at 500 °C	25.3	0.638	669	12.76
Furnace-treated Li-doped m-TiO2 at 500 °C	25.3	0.653	527	12.47
Laser-treated Li-doped m-TiO ₂ at 700-750 °C	25.3	0.726	517	11.21
Laser-treated Li-doped m-TiO ₂ at 800-850 °C	25.3	0.628	708	12.96
Laser-treated Li-doped m-TiO2 at 900-950 °C	25.3	0.617	784	13.20

Table S4 The Calculated details for the energy level of furnace-treated undoped m-TiO₂, Lidoped m-TiO₂ at 500°C and laser-treated Li-doped TiO₂ at 800-850 °C

Conditions	$E_f(\mathbf{eV})$	Eonset (eV)	E_g (eV)	<i>Ev</i> (eV)	<i>Ec</i> (eV)
Furnace-treated undoped m-TiO ₂ at 500 °C	-4.37	3.04	3.37	-7.41	-4.04
Furnace-treated Li-doped m-TiO ₂ at 500 °C	-4.41	3.06	3.38	-7.47	-4.09
Laser-treated Li- doped m-TiO ₂ at 800-850 °C	-4.39	3.09	3.40	-7.48	-4.08

Table S5 The ratio of shoulder peak area to main peak area of O 1s peak with furnace-treated undoped m-TiO₂, Li-doped m-TiO₂ and laser-treated Li-doped m-TiO₂.

Conditions	Ratio (Shoulder Peak Area/ Main Peak Area)
Furnace-treated undoped m-TiO ₂	0.26
Furnace-treated Li-doped m-TiO ₂	0.34
Laser-treated Li-doped m-TiO ₂	0.29

Table S6 Calculated parameters and trap density (N_t) for furnace-treated undoped m-TiO₂, Lidoped m-TiO₂ and laser-treated Li-doped m-TiO₂.

Samples	L (nm)	Er	V _{TFL} (V)	N_t (cm ⁻³)
Furnace-treated undoped m-TiO ₂	150	55	0.70	1.89*10 ¹⁷
Furnace-treated Li-doped m-TiO2	150	55	0.65	1.76*10 ¹⁷
Laser-treated Li-doped m-TiO ₂	150	55	0.58	1.57*10 ¹⁷

Table S7 TRPL parameters for the perovskite films deposited on the different ETLs.

Conditions	$ au_1(\mathbf{ns})$	$A_1(\%)$	$ au_2(\mathbf{ns})$	$A_2(\%)$	$ au_{avg}(\mathbf{ns})$
Furnace-treated undoped TiO ₂ at 500 °C	51.34	18.71	247.91	81.29	238.97
Furnace-treated Li-doped m-TiO ₂ at 500 °C	50.42	14.27	174.23	85.73	168.54
Laser-treated Li- doped m-TiO ₂ at 800-850 °C	31.79	18.75	168.29	81.25	162.59

Table S8 Resistance of the ITO electrodes (covered by m-TiO₂) annealed with furnace and laser treatments.

Conditions	Resistance (Ω)
Before Laser treatment	151.42 ± 15.36
Furnace-treated at 500 °C	721.78 ± 11.29
Laser-treated at 700-750 °C	410.25 ± 13.65
Laser-treated at 800-850 °C	435.63 ± 16.41
Laser-treated at 900-950 °C	491.88 ± 17.52

Table S9 EIS fitting parameters for the devices with furnace-treated undoped TiO₂, Li-doped m-TiO₂ at 500°C and laser treated Li-doped m-TiO₂ (800-850 °C).

Conditions	$R_{s}\left(\Omega ight)$	$R_{rec}\left(\Omega ight)$	<i>CPE</i> (F)
Furnace-treated undoped TiO ₂ at	47.6	1383.0	2 50-8
500 °C Furnace-treated	47.0	1565.0	2.50-0
Li-doped m-TiO ₂ at 500 °C	44.8	1542.0	3.2e-8
Laser-treated Li- doped m-TiO ₂ at 800-850 °C	40.4	3477.0	2.8e-8

Table S10 Summary of photovoltaic parameters for the $Cs_{0.1}FA_{0.9}PbI_3$ devices with the furnace- and laser-treated Li-doped m-TiO₂ films.

Conditions	Voc (V)	J_{SC} (mA·cm ⁻²)	FF (%)	Average PCE (%)	Champion PCE (%)
Furnace-treated at 500 °C	1.027±0.008	23.34±0.15	74.03±1.33	17.74±0.31	18.10
Laser-treated at 700-750 °C	1.023±0.006	23.28±0.13	74.01±1.14	17.62±0.30	18.03
Laser-treated at 800-850 °C	1.038±0.014	23.42±0.18	76.08±1.83	18.48±0.40	19.15
Laser-treated at 900-950 °C	1.027±0.008	23.40±0.18	74.91±1.47	18.00±0.40	19.05

Doping process	Processing temperature	Fabrication Conditions	Processing time (TiO ₂ + doping process)	Performance of PSCs
Laser process (Li)	700-900°C	Ambient (this work)	21s + 21s	19.15%
Furnace process (Li)	450-500°C	Ambient (this work)	1.5h + 1.5h	18.10%
Flame annealing (Co) ¹⁶	1000°C	Glove box	0.5h + 40s	19.6%
Furnace process (Li) ¹⁷	450-500°C	Glove box	1.5h + 1.5h	17.59%
Furnace process (Nb) ¹⁸	500°C	Glove box	0.5h+1.5h	13.4%
Hot plate (Nd) ¹⁹	450-600°C	Glove box	0.75h + 3h	18.1%
Furnace process (Zn) ²⁰	450-500°C	Glove box	Unmentioned + 0.5h	18.3%

Table S11 Comparison of laser processing and conditional furnace processing.

Table S12 The hysteresis index for the PSCs with the furnace-treated undoped m-TiO₂, furnace- and laser-treated Li-doped m-TiO₂.

Conditions	HI
Furnace-treated undoped m-TiO2 at 500 °C	0.38 ± 0.02
Furnace-treated Li-doped m-TiO ₂ at 500 °C	0.31 ± 0.01
Laser-treated Li-doped m-TiO2 at 700-750 °C	0.35 ± 0.02
Laser-treated Li-doped m-TiO2 at 800-850 °C	0.28 ± 0.02
Laser-treated Li-doped m-TiO2 at 900-950 °C	0.30 ± 0.01

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